Notice of References Cited

	lication/Control No. 06,410	Reexaminati	Applicant(s)/Patent Under Reexamination MUNRO ET AL.		
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Stev	en B. Theriault	2179	Page 1 of 3		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,421,008 A	05-1995	Banning et al.	707/4
*	В	US-5,515,488 A	05-1996	Hoppe et al.	345/440
*	С	US-5,606,691 A	02-1997	Watts et al.	707/4
*	D	US-5,838,965 A	11-1998	Kavanagh et al.	707/103R
*	Е	US-5,832,452 A	11-1998	Schneider et al.	705/5
*	F	US-5,909,678 A	06-1999	Bergman et al.	707/4
*	G	US-6,243,094 B1	06-2001	Sklar, Peter	715/853
*	Н	US-2001/0051943 A1	12-2001	Drucker et al.	707/3
*	1	US-6,326,962 B1	12-2001	Szabo, Andrew J.	715/762
*	J	US-2002/0087568 A1	07-2002	LeDonne et al.	707/100
*	K	US-2002/0103794 A1	08-2002	Chang, Kae-Por F.	707/3
*	L	US-2002/0169759 A1	11-2002	Kraft et al.	707/3
*	М	US-6,601,071 B1	07-2003	Bowker et al.	707/102

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination MUNRO ET AL. | Examiner | Art Unit | Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,640,221 B1	10-2003	Levine et al.	707/3
*	В	US-6,658,404 B1	12-2003	Cecchini, Albert B. P.	707/3
*	С	US-6,694,326 B2	02-2004	Mayhew et al.	707/102
*	D	US-2004/0215612 A1	10-2004	Brody, Moshe	707/003
*	Ε	US-2005/0005266 A1	01-2005	Datig, William E.	717/136
*	F	US-2005/0004911 A1	01-2005	Goldberg et al.	707/007
*	G	US-6,925,608 B1	08-2005	Neale et al.	715/763
*	Ι	US-6,947,928 B2	09-2005	Dettinger et al.	707/4
*	1	US-2005/0222984 A1	10-2005	Radestock et al.	707/003
*	J	US-2005/0256852 A1	11-2005	McNall et al.	707/003
*	к	US-2006/0106783 A1	05-2006	Saffer et al.	707/003
*	L	US-2006/0200462 A1	09-2006	Kadayam et al.	707/005
*	М	US-7,181,438 B1	02-2007	Szabo, Andrew	707/2

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0		0			
	Р					
	Q					
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 10/606,410 Examiner Steven B. Theriault Applicant(s)/Patent Under Reexamination MUNRO ET AL. Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2007/0081197 A1	04-2007	Omoigui, Nosa	358/403
*	В	US-2007/0156677 A1	07-2007	Szabo, Andrew	707/005
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-		1.00	
	1	US-			
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	К	US-			
	L	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.